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|--|--|--|--|---------------------------------------|-------------------------------|
| Substitute Form PTO-1449<br>(Modified)<br>CIPR JCS<br>MAR 19 2004<br>(37 CFR §1.98(b)) |  | U.S. Department of Commerce<br>Patent and Trademark Office |  | Attorney's Docket No.<br>14414-020001 | Application No.<br>10/761,862 |
| Information Disclosure Statement<br>by Applicant<br>(Use several sheets if necessary)  |  | Applicant<br>Dan Jin                                       |  |                                       |                               |
|  |  | Filing Date<br>January 21, 2004                            |  | Group Art Unit<br>(712)               |                               |

**U.S. Patent Documents**

| Examiner Initial | Desig. ID | Document Number | Publication Date | Patentee          | Class | Subclass | Filing Date If Appropriate |
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Examiner Signature

*R. H. Peleg*

Date Considered

*4/11/05*

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

| Substitute Form PTO-1449<br>(Modified)   |           | U.S. Department of Commerce<br>Patent and Trademark Office |                         | Attorney's Docket No.<br>14414-020001 | Application No.<br>10/761,862 |          |                            |
|--|-----------|--|-------------------------|---------------------------------------|-------------------------------|----------|----------------------------|
| <b>Information Disclosure Statement<br/>by Applicant</b><br>(Use several sheets if necessary)<br><br>(37 CFR §1.98(b)) |           | Applicant<br>Dan Jin                                       |                         |                                       |                               |          |                            |
|  |           | Filing Date<br>January 21, 2004                            | Group Art Unit<br>(712) |                                       |                               |          |                            |
| <b>U.S. Patent Documents</b>   |           |  |                         |                                       |                               |          |                            |
| Examiner Initial   | Desig. ID | Document Number  | Publication Date        | Patentee                              | Class                         | Subclass | Filing Date If Appropriate |
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| Examiner Initial   | Desig. ID | Document Number | Publication Date | Country or Patent Office | Class | Subclass | Translation<br>Yes      No |
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| <b>Other Documents (include Author, Title, Date, and Place of Publication)</b> |           |  |
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| ✓  | ATT       | Resnick et al., "Release Layers for Contact and Imprint Lithography," <i>Semicon. Int.</i> , June 2002, online version, 7 pgs.   |

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|--|----------------------------------|
| Examiner Signature<br><i>Kelli Peay</i>  | Date Considered<br><i>4/1/05</i> |
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